

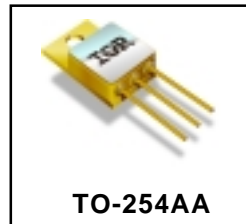
POWER MOSFET THRU-HOLE (TO-254AA)

IRFMG50 1000V, N-CHANNEL HEXFET® MOSFET TECHNOLOGY

Product Summary

Part Number	R _{DS(on)}	I _D
IRFMG50	2.0Ω	5.6A

HEXFET® MOSFET technology is the key to International Rectifier's advanced line of power MOSFET transistors. The efficient geometry design achieves very low on-state resistance combined with high transconductance. HEXFET transistors also feature all of the well-established advantages of MOSFETs, such as voltage control, very fast switching, ease of paralleling and electrical parameter temperature stability. They are well-suited for applications such as switching power supplies, motor controls, inverters, choppers, audio amplifiers, high energy pulse circuits, and virtually any application where high reliability is required. The HEXFET transistor's totally isolated package eliminates the need for additional isolating material between the device and the heatsink. This improves thermal efficiency and reduces drain capacitance.



TO-254AA

Features:

- Simple Drive Requirements
- Ease of Paralleling
- Hermetically Sealed
- Electrically Isolated
- Ceramic Eyelets

Absolute Maximum Ratings

	Parameter		Units
I _D @ V _{GS} = 10V, T _C = 25°C	Continuous Drain Current	5.6	A
I _D @ V _{GS} = 10V, T _C = 100°C	Continuous Drain Current	3.5	
I _{DM}	Pulsed Drain Current ①	22	
P _D @ T _C = 25°C	Max. Power Dissipation	150	W
	Linear Derating Factor	1.2	W/°C
V _{GS}	Gate-to-Source Voltage	±20	V
E _{AS}	Single Pulse Avalanche Energy ②	860	mJ
I _{AR}	Avalanche Current ①	5.6	A
E _{AR}	Repetitive Avalanche Energy ①	15	mJ
dv/dt	Peak Diode Recovery dv/dt ③	1.0	V/ns
T _J	Operating Junction	-55 to 150	°C
T _{STG}	Storage Temperature Range		
	Lead Temperature	300(0.063in./1.6mm from case for 10 sec)	
	Weight	9.3 (Typical)	g

For footnotes refer to the last page

Electrical Characteristics @ T_j = 25°C (Unless Otherwise Specified)

	Parameter	Min	Typ	Max	Units	Test Conditions
BVDSS	Drain-to-Source Breakdown Voltage	1000	—	—	V	V _{GS} = 0V, I _D = 1.0mA
ΔBVDSS/ΔT _J	Temperature Coefficient of Breakdown Voltage	—	1.4	—	V/°C	Reference to 25°C, I _D = 1.0mA
RDS(on)	Static Drain-to-Source On-State Resistance	—	—	2.0	Ω	V _{GS} = 10V, I _D = 3.5A ④
VGS(th)	Gate Threshold Voltage	2.0	—	4.0	V	V _{DS} = V _{GS} , I _D = 250μA
gfs	Forward Transconductance	5.2	—	—	S (r)	V _{DS} > 15V, I _{DS} = 3.5A ④
IDSS	Zero Gate Voltage Drain Current	—	—	25	μA	V _{DS} = 800V, V _{GS} = 0V
		—	—	250		V _{DS} = 800V, V _{GS} = 0V, T _J = 125°C
IGSS	Gate-to-Source Leakage Forward	—	—	100	nA	V _{GS} = 20V
IGSS	Gate-to-Source Leakage Reverse	—	—	-100		V _{GS} = -20V
Qg	Total Gate Charge	—	—	200	nC	V _{GS} = 10V, I _D = 5.6A V _{DS} = 400V
Qgs	Gate-to-Source Charge	—	—	20		
Qgd	Gate-to-Drain ('Miller') Charge	—	—	—		
td(on)	Turn-On Delay Time	—	—	30	ns	V _{DD} = 400V, I _D = 5.6A, R _G = 2.35Ω
tr	Rise Time	—	—	44		
td(off)	Turn-Off Delay Time	—	—	210		
tf	Fall Time	—	—	60		
LS + LD	Total Inductance	—	6.8	—	nH	Measured from Drain lead (6mm/0.25in. from package) to Source lead (6mm/0.25in. from package)
Ciss	Input Capacitance	—	2400	—	pF	V _{GS} = 0V, V _{DS} = 25V f = 1.0MHz
Coss	Output Capacitance	—	240	—		
Crss	Reverse Transfer Capacitance	—	80	—		
CDC	Drain-to-Case Capacitance	—	12	—		

Source-Drain Diode Ratings and Characteristics

	Parameter	Min	Typ	Max	Units	Test Conditions
I _S	Continuous Source Current (Body Diode)	—	—	5.6	A	T _J = 25°C, I _S = 5.6A, V _{GS} = 0V ④
I _{SM}	Pulse Source Current (Body Diode) ①	—	—	22		
V _{SD}	Diode Forward Voltage	—	—	1.8	V	T _J = 25°C, I _F = 5.6A, di/dt ≤ 100A/μs V _{DD} ≤ 50V ④
t _{rr}	Reverse Recovery Time	—	—	1200	nS	
Q _{RR}	Reverse Recovery Charge	—	—	8.4	μC	
t _{on}	Forward Turn-On Time	Intrinsic turn-on time is negligible. Turn-on speed is substantially controlled by L _S + L _D .				

Thermal Resistance

	Parameter	Min	Typ	Max	Units	Test Conditions
RthJC	Junction-to-Case	—	—	0.83	°C/W	Typical socket mount
RthCS	Case-to-sink	—	0.21	—		
RthJA	Junction-to-Ambient	—	—	48		

For footnotes refer to the last page

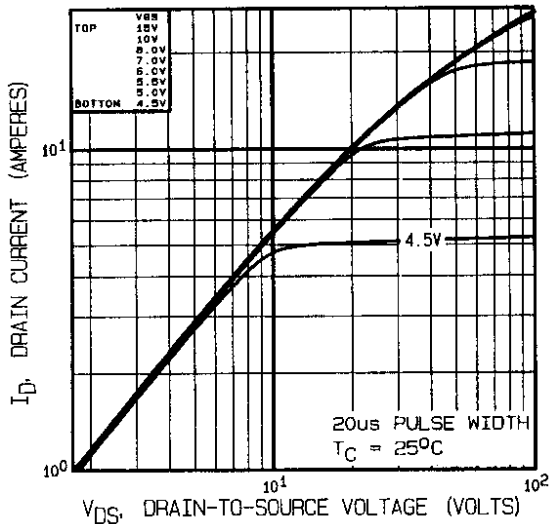


Fig 1. Typical Output Characteristics

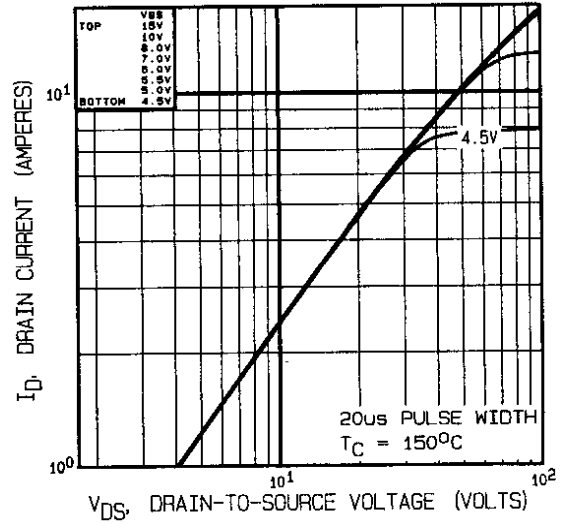


Fig 2. Typical Output Characteristics

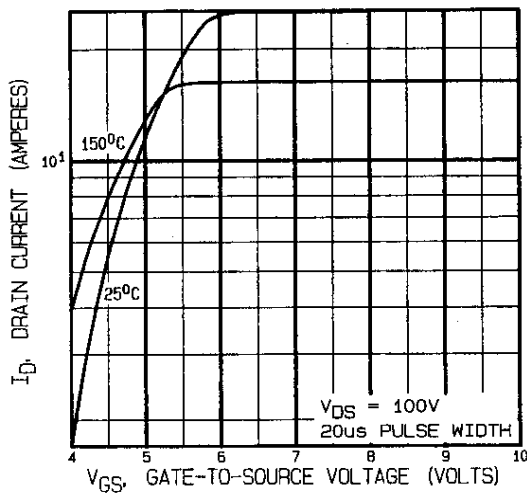


Fig 3. Typical Transfer Characteristics

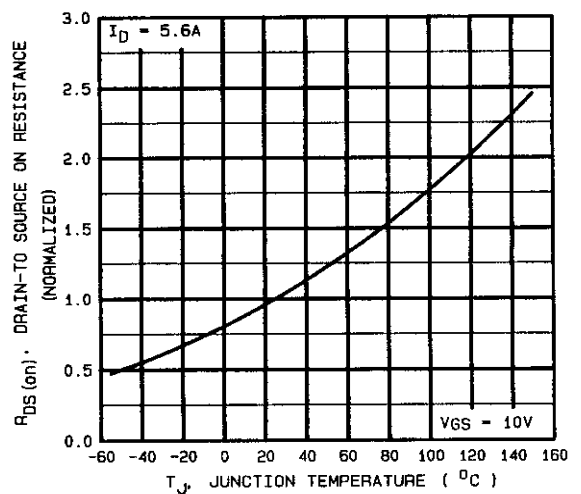


Fig 4. Normalized On-Resistance
Vs. Temperature

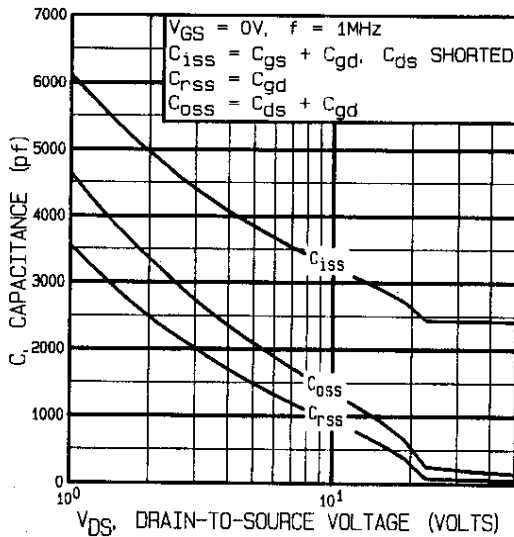


Fig 5. Typical Capacitance Vs. Drain-to-Source Voltage

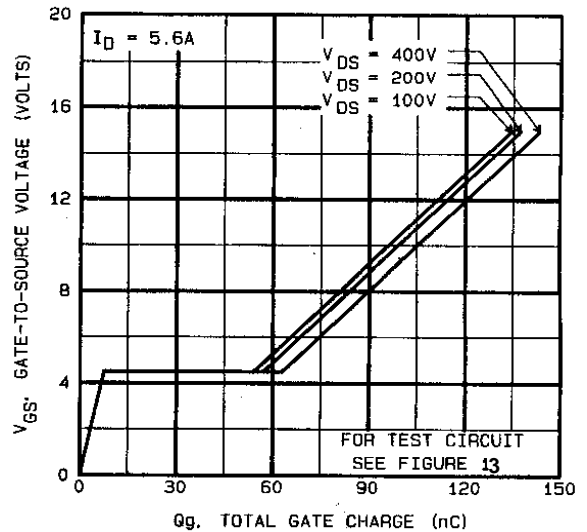


Fig 6. Typical Gate Charge Vs. Gate-to-Source Voltage

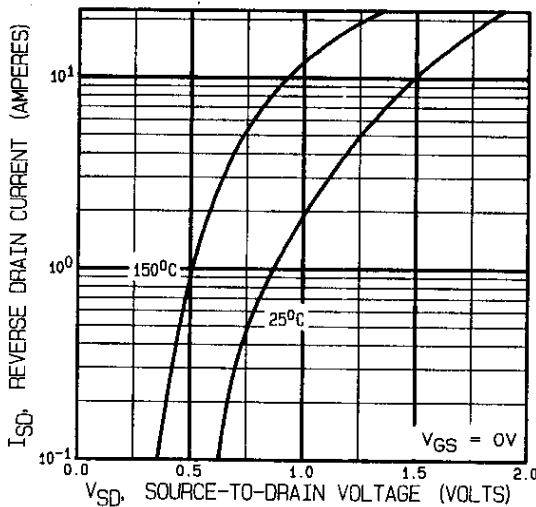


Fig 7. Typical Source-Drain Diode Forward Voltage

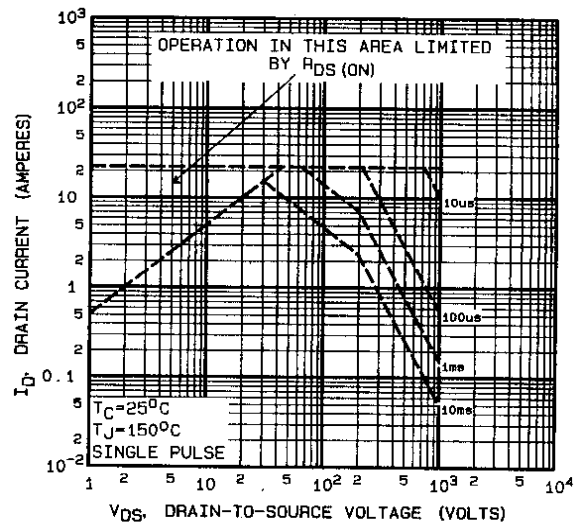


Fig 8. Maximum Safe Operating Area

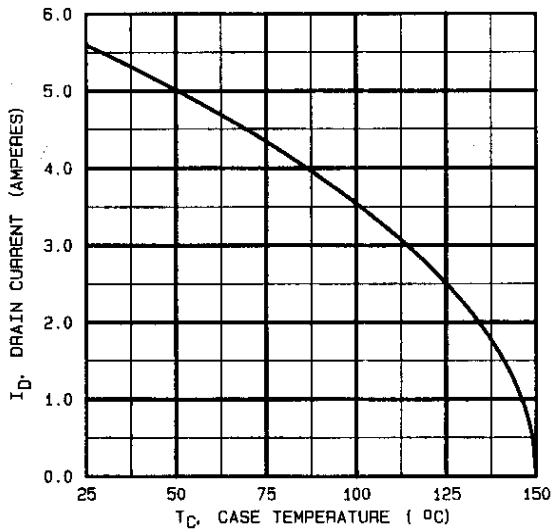


Fig 9. Maximum Drain Current Vs. Case Temperature

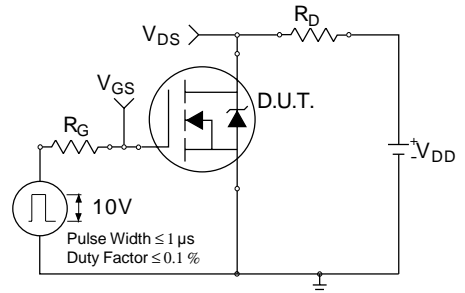


Fig 10a. Switching Time Test Circuit

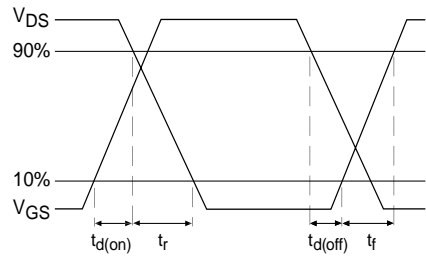


Fig 10b. Switching Time Waveforms

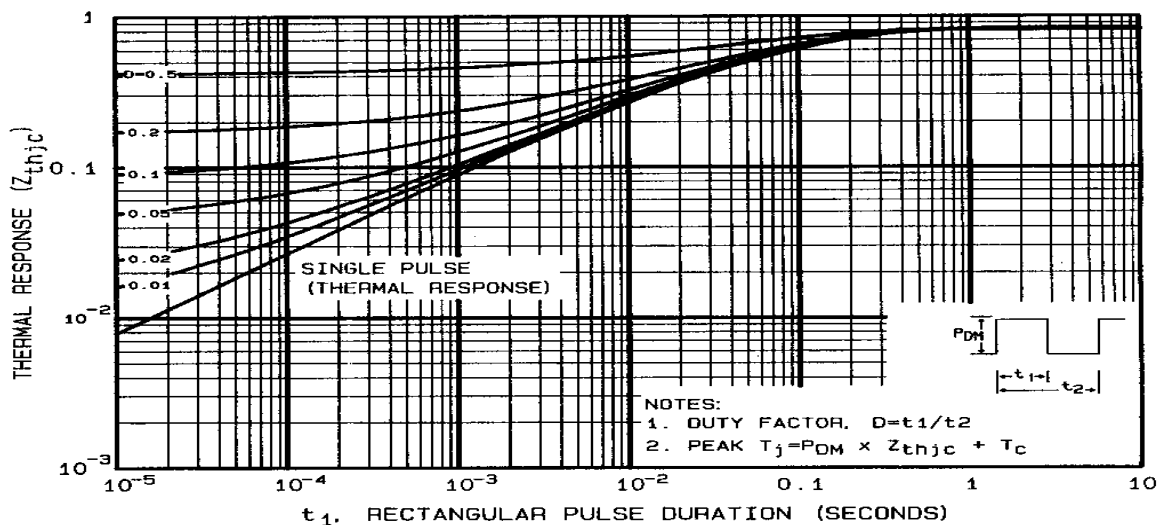


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

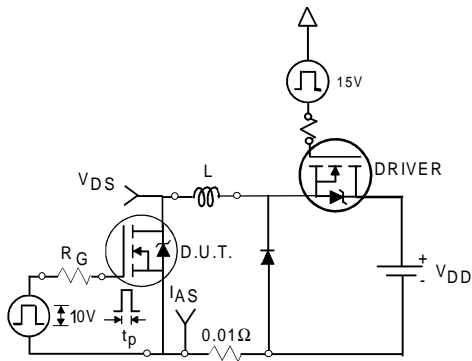


Fig 12a. Unclamped Inductive Test Circuit

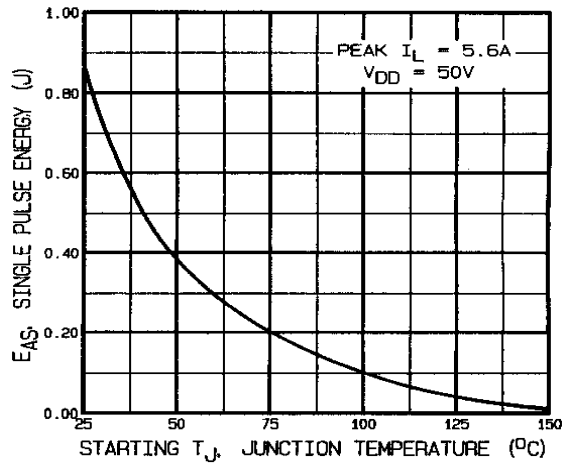
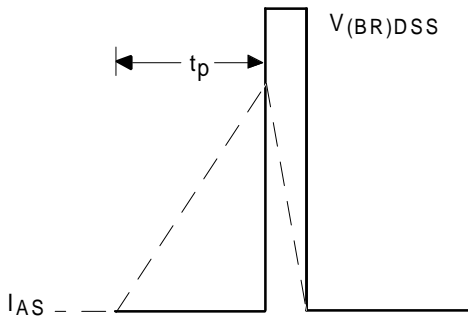
Fig 12c. Maximum Avalanche Energy
Vs. Drain Current

Fig 12b. Unclamped Inductive Waveforms

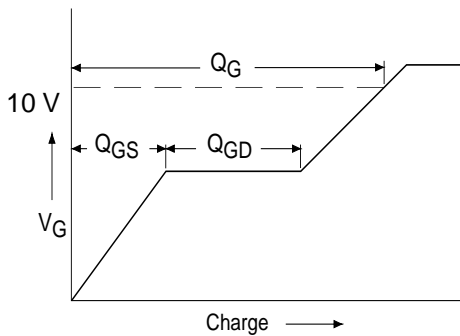


Fig 13a. Basic Gate Charge Waveform

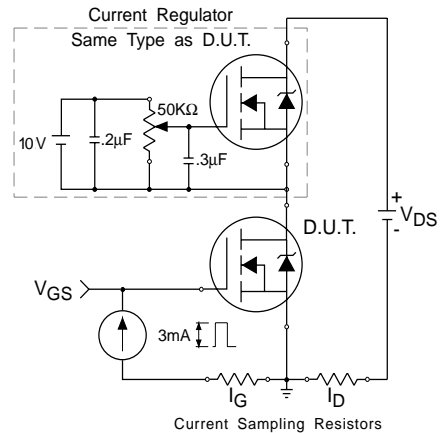
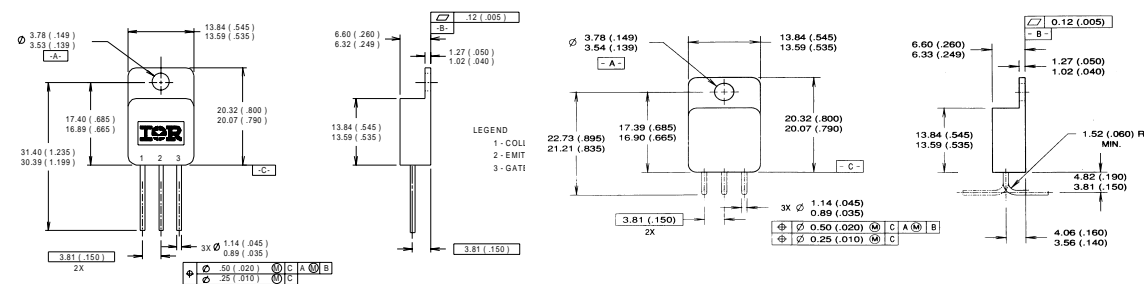


Fig 13b. Gate Charge Test Circuit

Footnotes:

- ① Repetitive Rating; Pulse width limited by maximum junction temperature.
- ② $V_{DD} = 50V$, starting $T_J = 25^\circ C$, $L = 54mH$
Peak $I_L = 5.6A$, $V_{GS} = 10V$
- ③ $I_{SD} \leq 5.6A$, $di/dt \leq 120A/\mu s$,
 $V_{DD} \leq 1000V$, $T_J \leq 150^\circ C$
- ④ Pulse width $\leq 300 \mu s$; Duty Cycle $\leq 2\%$

Case Outline and Dimensions — TO-254AA



NOTES:

1. DIMENSIONING & TOLERANCING PER ANSI Y14.5M-1982.
2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
3. LEADFORM IS AVAILABLE IN EITHER ORIENTATION:

LEGEND

- 1- DRAIN
2- SOURCE
3- GATE

CAUTION

BERYLLIA WARNING PER MIL-PRF-19500

Packages containing beryllia shall not be ground, sandblasted, machined or have other operations performed on them which will produce beryllia or beryllium dust. Furthermore, beryllium oxide packages shall not be placed in acids that will produce fumes containing beryllium.

International IOR Rectifier

IR WORLD HEADQUARTERS: 233 Kansas St., El Segundo, California 90245, USA Tel: (310) 252-7105
TAC Fax: (310) 252-7903

Visit us at www.irf.com for sales contact information.

Data and specifications subject to change without notice. 04/01